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April 2013



FGH40N60SFD 600 V, 40 A Field Stop IGBT

Features

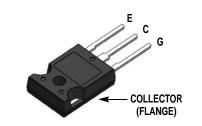
- High Current Capability
- Low Saturation Voltage: V_{CE(sat)} = 2.3 V @ I_C = 40 A
- High Input Impedance
- Fast Switching
- RoHS Compliant

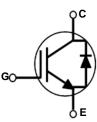
Applications

 Solar Inverter, UPS, Welder, PFC, Microwave Oven, Telecom, ESS

General Description

Using novel field stop IGBT technology, Fairchild[®]'s field stop IGBTs offer the optimum performance for solar inverter, UPS, welder, microwave oven, telecom, ESS and PFC applications where low conduction and switching losses are essential.





Absolute Maximum Ratings

Symbol	Description		Ratings	Unit	
V _{CES}	Collector to Emitter Voltage		600	V	
V _{GES}	Gate to Emitter Voltage		± 20	V	
I _C	Collector Current	@ T _C = 25°C	80	A	
	Collector Current	@ T _C = 100 ^o C	40	A	
I _{CM (1)}	Pulsed Collector Current	@ T _C = 25°C	120	A	
P _D	Maximum Power Dissipation	@ T _C = 25°C	290	W	
	Maximum Power Dissipation	@ T _C = 100 ^o C	116	W	
TJ	Operating Junction Temperature		-55 to +150	°C	
T _{stg}	Storage Temperature Range		-55 to +150	°C	
TL	Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds		300	°C	

Notes:

1: Repetitive rating: Pulse width limited by max. junction temperature

Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
R _{0JC} (IGBT) Thermal Resistance, Junction to Case		-	0.43	°C/W
$R_{\theta JC}$ (Diode)	Thermal Resistance, Junction to Case	-	1.45	°C/W
R_{\thetaJA}	Thermal Resistance, Junction to Ambient	-	40	°C/W

		Package	Packaging ackage Type		Qty per Tube		Max Qty per Box	
		FGH40N60SFDTU	TO-247)ea	-	
	al Chai	racteristics of th	-					1
Symbol		Parameter	Test	Conditions	Min.	Тур.	Max.	Unit
Off Charac	teristics							
BV _{CES}		to Emitter Breakdown Volt	ltage V _{GE} = 0V, I _C = 250μA		600	-	-	V
∆BV _{CES}		ure Coefficient of Breakdo)w/D	-				
ΔT_{J}	Voltage		$V_{GE} = 0V, I_0$		-	0.6	-	V/ºC
I _{CES}	Collector	Cut-Off Current	$V_{CE} = V_{CES}$, $V_{GE} = \overline{0V}$	-	-	250	μΑ
I _{GES}	G-E Leak	age Current	$V_{GE} = V_{GES}$	$V_{CE} = 0V$	-	-	±400	nA
On Charac	teristics							
V _{GE(th)}		shold Voltage	$I_{C} = 250 \mu A, V_{CE} = V_{GE}$		4.0	5.0	6.5	V
()			-	$I_{\rm C} = 40$ A, $V_{\rm GE} = 15$ V		2.3	2.9	V
V _{CE(sat)}	Collector to Emitter Saturation Voltage		age $I_C = 40A, V_C$	$I_{C} = 40A, V_{GE} = 15V,$ $T_{C} = 125^{\circ}C$		2.5	-	V
D		11			- I	ļ		Į
Dynamic C C _{ies}	Input Cap				-	2110	-	pF
C _{oes}		apacitance	V _{CE} = 30V,	$V_{CE} = 30V$, $V_{GE} = 0V$, f = 1MHz		200		pF
C _{res}		Transfer Capacitance	f = 1MHz			60	-	pF
ores	11010100					00		P
Switching	Characteri	stics						1
t _{d(on)}	Turn-On [Delay Time			-	25	-	ns
t _r	Rise Time	9			-	42	-	ns
t _{d(off)}	Turn-Off [Delay Time	$V_{CC} = 400 V$	′, I _C = 40A,	-	115	-	ns
t _f	Fall Time		$R_{G} = 10\Omega, V$	$R_G = 10\Omega$, $V_{GE} = 15V$, Inductive Load, $T_C = 25^{\circ}C$		27	54	ns
Eon	Turn-On S	Switching Loss				1.13	-	mJ
E _{off}	Turn-Off S	Switching Loss			-	0.31	-	mJ
E _{ts}	Total Swit	ching Loss				1.44	-	mJ
t _{d(on)}	Turn-On [Delay Time			-	24	-	ns
t _r	Rise Time	9			-	43	-	ns
t _{d(off)}	Turn-Off [Delay Time	V _{CC} = 400V	′, I _C = 40A,	-	120	-	ns
t _f	Fall Time		R _G = 10Ω, \	/ _{GE} = 15V,	-	30	-	ns
Eon	Turn-On S	Switching Loss	Inductive Lo	oad, T _C = 125°C	-	1.14	-	mJ
E _{off}	Turn-Off S	Switching Loss			-	0.48	-	mJ
E _{ts}	Total Swit	ching Loss			-	1.62	-	mJ
Qg	Total Gate	e Charge			-	120	-	nC
Q _{ge}	Gate to E	mitter Charge	$V_{CE} = 400V$, I _C = 40A,	-	14	-	nC
Q _{gc}		ollector Charge	V _{GE} = 15V		-	58	-	nC

Symbol	Parameter Test Conditions		าร	Min.	Тур.	Max	Unit
V _{FM}	Diode Forward Voltage	I _F = 20A	$T_{\rm C} = 25^{\rm o}{\rm C}$	-	1.95	2.6	V
			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	1.85	-	
t _{rr} Diode Reve	Diode Reverse Recovery Time		$T_C = 25^{\circ}C$	-	45	-	ns
			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	140	-	
Q _{rr}	Diode Reverse Recovery Charge		$T_C = 25^{\circ}C$	-	75	-	nC
			$T_{\rm C} = 125^{\rm o}{\rm C}$	-	375	-	





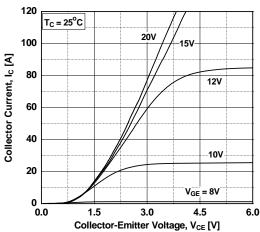


Figure 3. Typical Saturation Voltage Characteristics

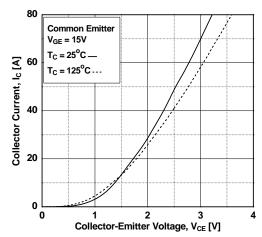


Figure 5. Saturation Voltage vs. Case Temperature at Variant Current Level

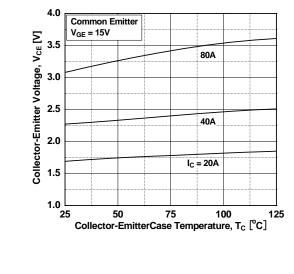


Figure 2. Typical Output Characteristics

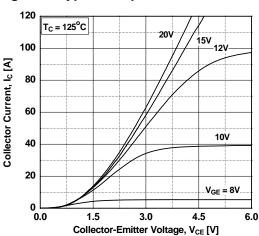


Figure 4. Transfer Characteristics

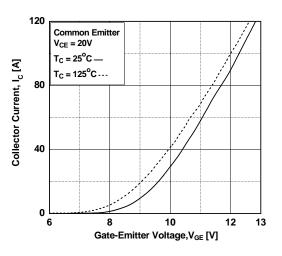
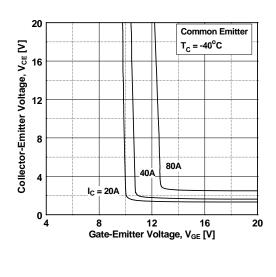


Figure 6. Saturation Voltage vs. V_{GE}



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Figure 7. Saturation Voltage vs. V_{GE} 20 Common Emitter Collector-Emitter Voltage, V_{CE} [V] $T_{C} = 25^{\circ}C$ 16 12 8 80A 40A 4 = 20A 0 ∟ 4 8 12 16 20 Gate-Emitter Voltage, V_{GE} [V] **Figure 9. Capacitance Characteristics** 5000 Common Emitter V_{GE} = 0V, f = 1MHz T_C = 25°C 4000 C_{iss} Capacitance [pF] 3000 C 2000

Typical Performance Characteristics

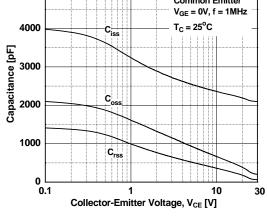


Figure 11. SOA Characteristics

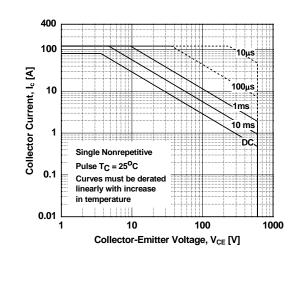


Figure 8. Saturation Voltage vs. V_{GE}

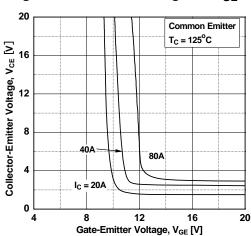


Figure 10. Gate charge Characteristics

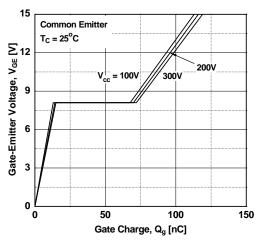
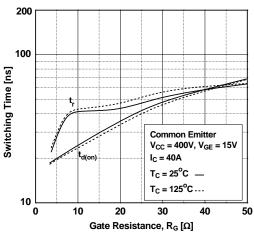
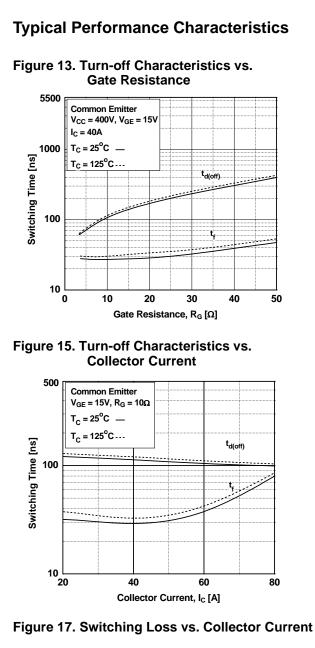
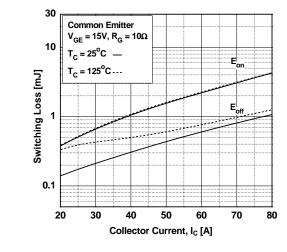


Figure 12. Turn-on Characteristics vs. **Gate Resistance**







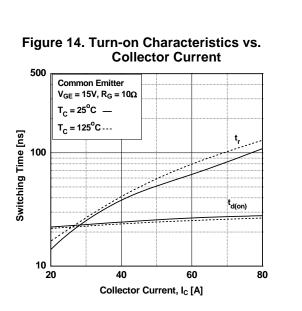


Figure 16. Switching Loss vs. Gate Resistance

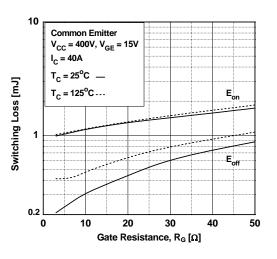
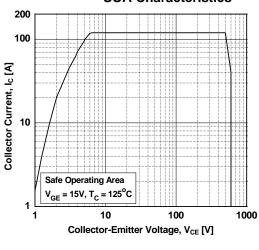
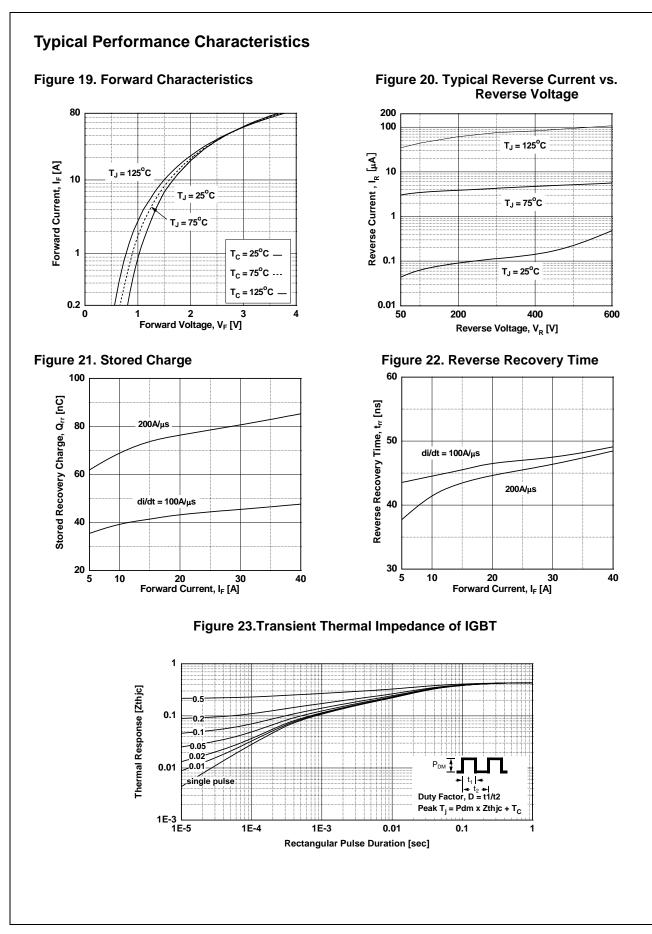
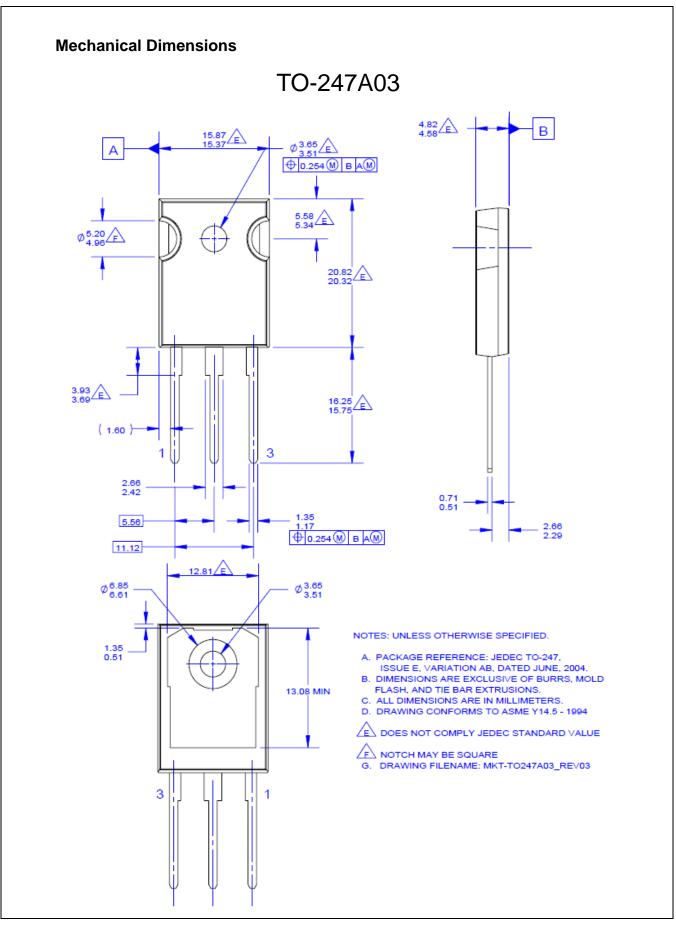


Figure 18. Turn off Switching SOA Characteristics



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